





# NFC TEST REPORT

No.121Z70218-IOT09

for

**SAMSUNG Electronics Co., Ltd.** 

Multi-band GSM/WCDMA/LTE/5GNR Phone

with Bluetooth, WLAN

SM-A226BR/DSN,SM-A226BR/N

FCC ID: ZCASMA226BRN

with

Hardware Version: REV1.0

Software Version: A226BR.001

Issued Date: 2021-06-29

#### Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of CTTL.

The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the U.S.Government.

#### **Test Laboratory:**

#### CTTL-Telecommunication Technology Labs, CAICT

No. 52, Huayuan North Road, Haidian District, Beijing, P. R. China 100191.

Tel:+86(0)10-62304633-2512, Fax:+86(0)10-62304633-2504

Email: cttl\_terminals@caict.ac.cn, website: www.caict.ac.cn





# **REPORT HISTORY**

Report Number	Revision	Description	Issue Date
I21Z70218-IOT09	Rev.0	1st edition	2021-06-29





# **CONTENTS**

1.	TEST LABORATORY	4
	1.1. INTRODUCTION & ACCREDITATION	4
	1.2. TESTING LOCATION	4
	1.3. TESTING ENVIRONMENT	5
	1.4. PROJECT DATA	5
	1.5. SIGNATURE	5
2.	CLIENT INFORMATION	6
	2.1. APPLICANT INFORMATION	6
	2.2. MANUFACTURER INFORMATION	6
3.	EQUIPMENT UNDER TEST (EUT) AND ANCILLARY EQUIPMENT (AE)	7
	3.1. ABOUT EUT	7
	3.2. INTERNAL IDENTIFICATION OF EUT	7
	3.3. INTERNAL IDENTIFICATION OF AE	8
	3.4. EUT SET-UPS	9
4.	REFERENCE DOCUMENTS	10
	4.1. DOCUMENTS SUPPLIED BY APPLICANT	10
	4.2. REFERENCE DOCUMENTS FOR TESTING	10
5.	TEST RESULTS	11
	5.1. SUMMARY OF TEST RESULTS	11
	5.2. STATEMENTS	12
6.	TEST FACILITIES UTILIZED	13
7.	MEASUREMENT UNCERTAINTY	14
A	NNEX A: EUT PARAMETERS	15
A	NNEX B: DETAILED TEST RESULTS	16
A	NNEX C: PERSONS INVOLVED IN THIS TESTING	31
	NNEX D. ACCREDITATION CERTIFICATE	32





# 1. Test Laboratory

## 1.1. Introduction & Accreditation

**Telecommunication Technology Labs, CAICT** is an ISO/IEC 17025:2017 accredited test laboratory under NATIONAL VOLUNTARY LABORATORY ACCREDITATION PROGRAM (NVLAP) with lab code 600118-0, and is also an FCC accredited test laboratory (CN5017), and ISED accredited test laboratory (ISED#: 24849). The detail accreditation scope can be found on NVLAP website.

## 1.2. Testing Location

Location 1: CTTL(huayuan North Road)

Address: No. 52, Huayuan North Road, Haidian District, Beijing,

P. R. China 100191

Location 2: CTTL(CuiHu)

Address: CuiHu Cloud Center No.1 Gaolizhang Road, Wenquan

Town, Haidian District, Beijing, China





## 1.3. <u>Testing Environment</u>

Normal Temperature: 15-35°C

Extreme Temperature: -20/+50°C

Normal Relative Humidity: 20-75%

Normal Air Pressure: 86Kpa-106Kpa

## 1.4. Project data

Testing Start Date: 2021-03-29

Testing End Date: 2021-04-28

## 1.5. Signature

周纸

Zhou Bin (Prepared this test report)

100

Zhang Qiang (Reviewed this test report)

Zhu Liang

(Approved this test report)





# 2. Client Information

## 2.1. Applicant Information

Company Name: SAMSUNG Electronics Co.,Ltd.

Address: 19 Chapin Rd., Building D Pine Brook, NJ 07058

Country: Korea

Contact: Jenni Chun

Telephone: +1-201-937-4203

E-mail: j1.chun@samsung.com

## 2.2. Manufacturer Information

Company Name: SAMSUNG Electronics Co.,Ltd.

Samsung R5, Maetan dong 129, Samsung ro Youngtong gu, Suwon city

Address: 443 742,Korea

Country: Korea

Contact: Kobe Cho

Telephone: +82-10-2722-4159

E-mail: ggobi.cho@samsung.com





## 3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

### 3.1. About EUT

Description Multi-band GSM/WCDMA/LTE/5GNR Phone with

Bluetooth, WLAN

Model name/HVIN SM-A226BR/DSN,SM-A226BR/N

Brand name SAMSUNG

FCC ID ZCASMA226BRN UMTS Frequency Band(s) FDDI/II/IV/V/VIII

GSM Frequency Band(s) GSM850/900/1800/1900

E-UTRA Frequency Band(s) FDD1/2/3/4/5/7/8/12/17/20/26/28/28a/28b/66

TDD38/40/41

5G NR Band(s) n1/n3/n5/n7/n8/n28/n38/n40/n41/n78/n79

EN-DC Band(s) 1A-n1A/n3A/n7A/n28A/n40A/n78A 2A-n28A;3A-

n1A/n7A/n28A/n78A;5A-n7A/n78A;7A-

n1A/n3A/n5A/n28A/n78A;28A-

n1A/n3A/n7A/n78A;40A-n1A/n78A;66A-n5A/n28A;1A-3A-n7A/n28A/n78A;1A-7A-

n3A/n28A/n78A;1A-28A-n3A/n7A/n78A;3A-3A-n1A/n7A/n78A;3A-7A-n1A/n28A/n78A;3A-28A-n1A/n7A/n78A;3A-40A-n1A/n78A;7A-28A-

n1A/n3A/n78A;66A-66A-

n5A;66A n7A.66A 66A n7A.

Operating Temperature -10/+55°C
Nominal Voltage 3.85V
Extreme High Voltage 4.4V
Extreme Low Voltage 3.5V

#### 3.2. Internal Identification of EUT

EUT ID*	IMEI/SNI	<b>HW Version</b>	SW Version	Date of receipt
16a	357297120031332/ 357752230031333	REV1.0	A226B.001	2021-03-29
15a	357297120031530/ 357752230031531	REV1.0	A226B.001	2021-03-29

<sup>\*</sup>EUT ID: is used to identify the test sample in the lab internally.





# 3.3. Internal Identification of AE

AE ID*	Description	SN
AE1	Charger1	/
AE2	Charger2	/
AE3	Charger3	1
AE4	USB cable1	1
AE5	USB cable2	1
AE6	USB cable3	1
AE7	USB cable4	1
AE8	battery	/
AE1		
Model	EP-TA200	
Manufacturer	RFTECH	
Length of cable	1	
AE2		
Model	EP-TA200	
Manufacturer	Dongwon	
Length of cable	1	
AE3		
Model	EP-TA200	
Manufacturer	SOLUM	
Length of cable	1	
AE4		
Model	EP-DR140AWE	
Manufacturer	RFTECH Co., Ltd.	
Length of cable	/	
AE5		
Model	EP-DR140AWE	
Manufacturer	Ningbo Broad Telecommun	ication Co., Ltd
Length of cable	1	
AE6		
Model	EP-DR140AWE	
Manufacturer	DONGGUAN KSD CO.,LTI	)
Length of cable	1	
AE7		
Model	EP-DR140AWE	
Manufacturer	CRESYN HANOI Co.,Ltd	
Length of cable	1	
AE8		





Model SCUD-WT-W1

Manufacturer SCUD(Fujian)Electronic Co.,Ltd

Capacitance 4900mAh Nominal voltage 3.85V

### 3.4. EUT Set-ups

**Table 1: Eut Set-ups** 

EUT Set-up No.	Combination of EUT and AE	Remarks
Set.NFC01	15a + AE1 + NFC Card	
Set.NFC02	15a + NFC Card	
Set. NFC03	16a	

The Transmit State of NFC: the NFC function is on. The EUT will transmit the NFC data and command continuously during the test.

The Transmit state without modulation: The EUT will transmit the CW signal at the operating frequency.

<sup>\*</sup>AE ID: is used to identify the ancillary equipment in the lab internally.





# 4. Reference Documents

# 4.1. Documents supplied by applicant

EUT parameters, referring to Annex A for detailed information, are supplied by the client or manufacturer, which are the bases of testing.

## 4.2. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
CFR 47 Part 2	Part 2 — Frequency Allocations and Radio Treaty Matters; General Rules and Regulations.	2019
CFR 47 Part 15	Part 15 — Radio Frequency Devices.	2019
	Subpart C — Intentional Radiators.	
	§ 15.35 Measurement detector functions and bandwidths.	
	§ 15.207 Conducted limits.	
	§ 15.209 Radiated emission limits, general requirements.	
	§ 15.215 Additional provisions to the general radiated emission limitations.	
	§ 15.225 Operation within the band 13.110–14.010 MHz.	
ANSI C63.10	American National Standard of Procedures for Compliance	2020
	Testing of Unlicensed Wireless Devices	





# 5. Test Results

# 5.1. Summary of Test Results

**Table 2: Summary of Test Results** 

No	Test Cases	Clause in Regulation	Section in This Report	Verdict
1	Electric Field Strength of Fundamental Emissions	CFR 47 § 15.225(a)	B.1	P(Set. NFC02)
2	Electric Field Strength of Outside the Allocated Bands	CFR 47 § 15.225(b) CFR 47 § 15.225(c)	D.1	P(Set. NFC02)
3	Electric Field Radiated	CFR 47 § 15.209	B.2	P(Set. NFC01)
	Emissions	CFR 47 § 15.225(d)	B.3	P(Set. NFC01)
4	Frequency Tolerance	CFR 47 § 15.225(e)	B.4	P(Set. NFC03)
5	20dB Bandwidth	CFR 47 § 15.215(c)	B.5	P(Set. NFC03)
6	Conducted Emissions	CFR 47 § 15.207	B.6	P(Set. NFC01)
The measurement is carried out according to ANSI C63.10. See <b>ANNEX B</b> for details.				

#### **Test Conditions:**

For this report, all the test cases listed above were tested under normal Temperature, Voltage, humidity and Air Pressure except the Frequency Tolerance test case. The specific conditions of Frequency Tolerance test case are listed in section B.4.3

#### See Table 3 for terms for result verdict:

**Table 3 Terms for result verdict** 

Р	Pass, The EUT complies with the essential requirements in the standard.
NP	Not Perform, The test was not performed by CTTL
NA	Not Applicable, The test was not applicable
F	Fail, The EUT does not comply with the essential requirements in the standard





## 5.2. Statements

This model SM-A226BR/DSN,SM-A226BR/N is a variant product of the model SM-A226B/DSN.All the tests are performed on the SM-A226B/DSN.

The test cases listed in Section 5.1 of this report for the EUT specified in Section 3 were performed by CTTL according to the reference documents in Section 4.

The EUT meets all applicable requirements of the regulations and standards in Section 4.2





# 6. Test Facilities Utilized

**Table 4: Test Facilities Utilized** 

NO.	NAME	TYPE	SERIES NUMBER	PRODUCER	CAL. DUE DATE	CAL. INTERVAL
1.	Spectrum Analyzer	RSA3408A	B010277	Tektronix	2021-10-23	1 Year
2.	Climatic chamber	SH242	93008658	ESPEC	2022-01-22	1 Year
3.	Test Receiver	ESU26	100235	Rohde & Schwarz	2022-02-23	1 Year
4.	BiLog Antenna	VULB9163	9163-483	Schwarzbeck	2021-08-27	1 Year
5.	LISN	ENV216	101200	R&S	2021-05-19	1 Year
6.	Test Receiver	ESCI 3	100344	R&S	2022-02-23	1 Year
7.	H-field Antenna	HFH2-Z2	829324	R&S	2021-12-10	1 Year





# 7. Measurement Uncertainty

**Table 5: Measurement Uncertainty** 

Item	Uncertainty
Frequency Tolerance	<i>U</i> =77 Hz, k=2
20dB Bandwidth	<i>U</i> =77 Hz, k=2
Radiated Emissions (<1GHz)	<i>U</i> =4.86 dB, k=2
Radiated Emissions (>1GHz)	<i>U</i> =5.16 dB, k=2
Conducted emission	<i>U</i> = 3.08 dB, k=2





# **ANNEX A: EUT parameters**

/





## **ANNEX B: Detailed Test Results**

## **B.1. Electric Field Strength of Fundamental and Outside the Allocated bands**

#### **B.1.1. Reference**

See Clause 4, Clause 5 of ANSI C63.10-2013 generally.

#### **B.1.2. Measurement Methods**

The transmitter carrier output levels (E-Field) from the EUT are measured in a semi-anechoic chamber. The EUT is placed on a non-conductive stand of 80cm high, and at a measurement distance of 3m from the receiving antenna. The center of the receiving loop antenna is 1.0 meter above the ground. The E-field is measured with a shielded loop antenna connected to a measurement receiver. Detected E-field was maximized by rotating the EUT through 360° and adjusting the receiving antenna polarizations. The maximization processes were repeated with the EUT positioned respectively in its three orthogonal axes. The measurements were performed with the peak detector and if required, the quasi-peak detector.

The measurement bandwidth is:

Table B-1: Measurement bandwidth

Frequency of Emission (MHz)	RBW/VBW
12.56-14.56	10/30 kHz

The E-field measured at 3m is calculated as:

E-field  $(dB\mu V/m) = Rx (dB\mu V) + Cable Loss (dB) + AF@3m (dB/m)$ 





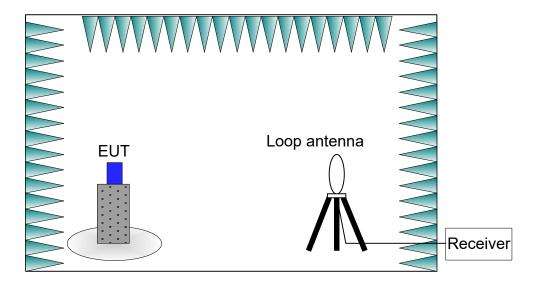


Figure B-1: Measurement Setup

### **B.1.3. EUT Operating Mode and Test Conditions**

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT is powered by a travel adapter.

All possible configurations were investigated and only the worst case is reported.

During the measurements, the ambient temperature of the electromagnetic anechoic chamber is in the range of 15  $\sim$  25  $^{\circ}$ C.

#### B.1.4. Limits

**Table B-2:** Limits

Frequency Range (MHz)	E-field Strength Limit @ 30 m	E-field Strength Limit @ 3 m	
Frequency Range (MHZ)	(μ <b>V/m</b> )	(dBµV/m)	
13.560 ± 0.007	+15,848	124	
13.410 to 13.553	+334	90	
13.567 to 13.710			
13.110 to 13.410	+106	81	
13.710 to 14.010		<u>-</u> .	

Note: Where the limits have been defined at one distance, and a signal level measured at another, the limits have been extrapolated using the following formula:





Extrapolation(dB) =  $40\log_{10}$  (Measurement Distance/Specification Distance)

#### **B.1.5. Measurement Results**

Measurement results of normal conditions see Figure B-2 for different set-ups of EUT. The results displayed take into account applicable antenna factors and cable losses.

Conclusions: Set.NFC02, PASS.

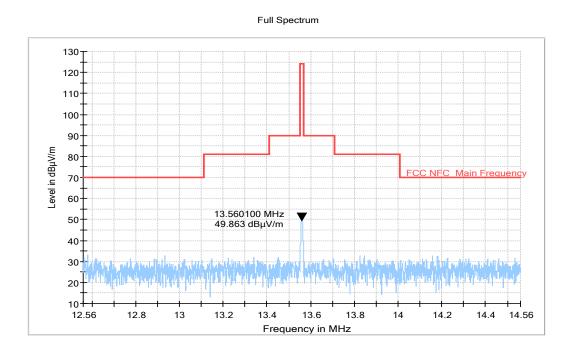


Figure B-2: Measurement results for Electric Field Strength of Fundamental and Outside the Allocated bands

## **B.2. Electric Field Radiated Emissions (< 30MHz)**

#### **B.2.1. Reference**

See Clause 6.4 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

#### **B.2.2. Measurement Methods**

The transmitter carrier output levels (E-Field) from the EUT are measured in a semi-anechoic chamber. The EUT is placed on a non-conductive stand of 80cm high, and at a measurement distance of 3m from the receiving antenna. The center of the receiving loop antenna is 1.0 meter





above the ground. The E-field is measured with a shielded loop antenna connected to a measurement receiver. Detected E-field was maximized by rotating the EUT through 360° and adjusting the receiving antenna polarizations. The maximization processes were repeated with the EUT positioned respectively in its three orthogonal axes. The measurements were performed with the peak detector and if required, the quasi-peak detector.

The measurement bandwidth is:

**Table B-3:** Measurement bandwidth

Frequency of Emission (MHz)	RBW/VBW
0.009-0.15	100/300 Hz
0.15-30	10/30 kHz

The E-field measured at 3m is calculated as:

E-field  $(dB\mu V/m) = Rx (dB\mu V) + Cable Loss (dB) + AF@3m (dB/m)$ 

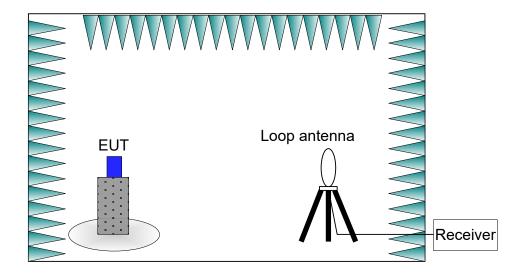


Figure B-3: Measurement Setup

#### **B.2.3. EUT Operating Mode and Test Conditions**

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT is powered by a travel adapter.

All possible configurations were investigated and only the worst case is reported.

During the measurements, the ambient temperature of the electromagnetic anechoic chamber is ©Copyright. All rights reserved by CTTL.





in the range of 15  $\sim$  25  $^{\circ}$ C.

#### B.2.4. Limits

**Table B-4:** Limits

Frequency Range (MHz)	E-field Strength Limit @ 30m (mV/m)	E-field Strength Limit @ 3m
0.009-0.490	2400/F(kHz)	129-94
0.490-1.705	24000/F(kHz)	74-63
1.705-30	30	70

Note: Where the limits have been defined at one distance, and a signal level measured at another, the limits have been extrapolated using the following formula:

Extrapolation(dB) =  $40\log_{10}$  (Measurement Distance/Specification Distance)

### **B.2.5. Measurement Results**

Measurement results of normal conditions see Figure B-4 for different set-ups of EUT. The results displayed take into account applicable antenna factors and cable losses.

Conclusions: Set.NFC01, PASS.

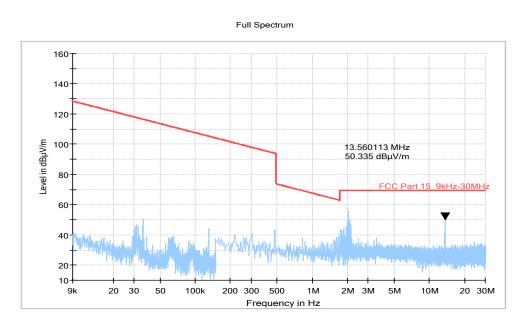


Figure B-4: Measurement results for Electric Field Radiated Emissions (< 30MHz)





## B.3. Electric Field Radiated Emissions (≥30MHz)

#### **B.3.1. Reference**

See Clause 6.5 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

#### **B.3.2. Measurement Methods**

The electric field radiated emissions from the EUT are measured in a semi-anechoic chamber. The EUT is placed on a non-conductive stand of 80cm high, and at a measurement distance of 10m from the receiving antenna. The receiving antennas connected to a measurement receiver. In order to search for maximum field strength emitted from the EUT, the receiving antenna can be moved between the height of 1.0 m to 4.0 m. Detected E-field was maximized at each frequency by rotating the EUT through 360° and adjusting the receiving antenna positions for both vertical and horizontal antenna polarizations. The maximization processes were repeated with the EUT positioned respectively in its three orthogonal axes. The measurements were performed with the peak detector and if required, the quasi-peak detector.

The measurement bandwidth is:

**Table B-5:** Measurement bandwidth

Frequency of Emission (MHz)	RBW/VBW
30-1000	120kHz

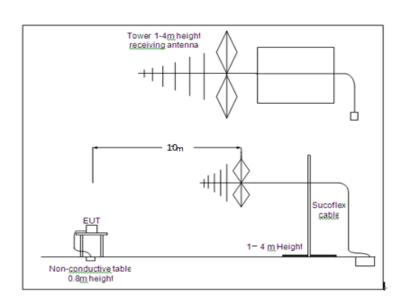


Figure B-5: Measurement Setup





#### **B.3.3. EUT Operating Mode and Test Conditions**

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT had been connected to a travel adapter.

All possible configurations were investigated and only the worst case is reported.

During the measurements, the ambient temperature of the electromagnetic anechoic chamber is in the range of 15  $\sim$  25  $^{\circ}$ C.

#### B.3.4. Limits

**Table B-6:** Limits

Frequency Range (MHz)	E-field Strength Limit @ 3m (mV/m)	E-field Strength Limit @ 3m (dBµV/m)	E-field Strength Limit @ 10m (dBµV/m)
30-88	100	40	30
88-216	150	43.5	33.5
216-960	200	46	36
960-1000	500	54	44

### **B.3.5. Measurement Results**

Measurement results of normal conditions see Figure B-6 for different set-ups of EUT. The results displayed take into account applicable antenna factors and cable losses.

Conclusions: Set.NFC01, PASS.





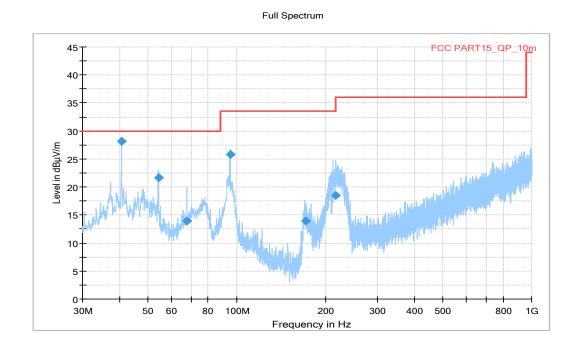


Figure B-6: Measurement results for Electric Field Radiated Emissions (≥30MHz)

## Final\_Result

Frequency	QuasiPeak	Height	Polarization	Azimuth	Margin	Limit
(MHz)	(dBµV/m)	(cm)		(deg)	(dB)	(dBµV/m)
40.670000	28.13	102.0	v	-2.0	1.87	30.00
54.250000	21.65	101.0	v	-21.0	8.35	30.00
67.733000	13.91	177.0	v	248.0	16.09	30.00
94.893000	25.77	178.0	v	276.0	7.75	33.50
171.135000	13.91	120.0	v	-12.0	19.61	33.50
215.852000	18.51	116.0	v	-11.0	15.01	33.50

## **B.4. Frequency Tolerance**

## B.4.1. Reference

See Clause 6.8 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.





#### **B.4.2. Measurement Methods**

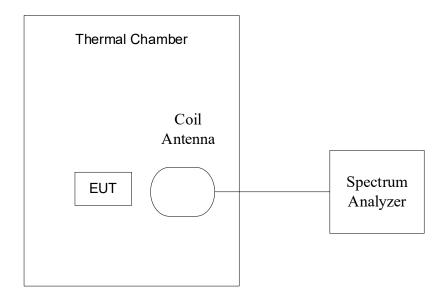


Figure B-7: Measurement Setup

The transmitter output signal was picked up by coil antenna connected to the spectrum analyzer. The center frequency was measured with 30Hz RBW and 1kHz span.

During the test, the EUT was placed in a thermal chamber until thermal balance and lasting appropriate time.

### **B.4.3. EUT Operating Mode and Test Conditions**

The measurement of EUT was carried out under the transmit state of without modulation (See 3.4).

EUT had not been connected to a travel adapter. The frequency stability was measured with the different voltage and temperature combinations:

- a) The nominal voltage 3.85V(See 3.1)was used and the temperature was varied from -20℃ to +50℃ in 10℃ increments using an environmental chamber.
- b) The  $20^{\circ}$ C was used and the voltages were 3.5V, 3.85V and 4.4V (The extreme low voltage ,the nominal voltage and the extreme high voltage defined in section 3.1).

The details were as following:





Test items	Voltage	Temperature
Frequency		-20℃
stability with respect to ambient		-10℃
temperature	3.85V	0℃
		10℃
		20℃
		30℃
		40℃
		50℃
Frequency stability	3.5V	
when varying supply voltage	3.85V	<b>20</b> ℃
	4.4V	

### **B.4.4. Test Layouts**

See B.4.2.

#### B.4.5. Limits

The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency.

### **B.4.6. Measurement Results**

Measurement results see Table B-8 for different test conditions.

Conclusions: Set.NFC03, PASS.

**Table B-8:** Measurement results for Frequency Tolerance

Temperature	Voltage	Frequency (MHz)					
romporaturo	vollago	Startup 2 Min Later 5 Min Later 10 Min Later					
-20°C	3.85V	13.560031875 13.560031250 13.560023750 13.5600212					





-10°C	3.85V	13.560043125	13.560043125   13.560054375		13.560053750	
0℃	3.85V	13.560063125 13.5600626		13.560062250	13.560061875	
10℃	3.85V	13.560054375	13.560051875	13.560051250	13.560050625	
20℃	3.85V	13.560049375	13.560029375	13.560025625	13.560023750	
30℃	3.85V	13.560014375	13.560003125	13.559960625	13.559985625	
40°C	3.85V	13.559984375	13.559970125	13.559956875	13.559955625	
50°C	3.85V	13.559943125	13.559933125	13.559929375	13.559926875	
20℃	3.5V	13.560023125	13.560021875	13.560020625	13.560018125	
20℃	4.4 V	13.560000625	13.560006875	13.560018750	13.560019375	
		Frequency Error (%)				
Temperature	Voltage		' '	( )		
Temperature	Voltage	Startup	2 Min Later	5 Min Later	10 Min Later	
Temperature -20℃	Voltage 3.85V	Startup 0.000			10 Min Later 0.000	
			2 Min Later	5 Min Later		
-20°C	3.85V	0.000	2 Min Later 0.000	5 Min Later 0.000	0.000	
-20℃ -10℃	3.85V 3.85V	0.000	2 Min Later 0.000 0.000	5 Min Later 0.000 0.000	0.000	
-20℃ -10℃ 0℃	3.85V 3.85V 3.85V	0.000 0.000 0.000	2 Min Later 0.000 0.000 0.000	5 Min Later 0.000 0.000 0.000	0.000 0.000 0.000	
-20°C -10°C 0°C 10°C	3.85V 3.85V 3.85V 3.85V	0.000 0.000 0.000 0.000	2 Min Later 0.000 0.000 0.000 0.000	5 Min Later 0.000 0.000 0.000 0.000	0.000 0.000 0.000 0.000	
-20℃ -10℃ 0℃ 10℃ 20℃	3.85V 3.85V 3.85V 3.85V 3.85V	0.000 0.000 0.000 0.000	2 Min Later  0.000  0.000  0.000  0.000  0.000	5 Min Later  0.000  0.000  0.000  0.000  0.000	0.000 0.000 0.000 0.000	
-20°C -10°C 0°C 10°C 20°C 30°C	3.85V 3.85V 3.85V 3.85V 3.85V	0.000 0.000 0.000 0.000 0.000	2 Min Later  0.000  0.000  0.000  0.000  0.000  0.000	5 Min Later  0.000  0.000  0.000  0.000  0.000  0.000	0.000 0.000 0.000 0.000 0.000	
-20°C -10°C 0°C 10°C 20°C 30°C 40°C	3.85V 3.85V 3.85V 3.85V 3.85V 3.85V	0.000 0.000 0.000 0.000 0.000 0.000	2 Min Later  0.000  0.000  0.000  0.000  0.000  0.000  0.000	5 Min Later  0.000  0.000  0.000  0.000  0.000  0.000  0.000	0.000 0.000 0.000 0.000 0.000 0.000	

## **B.4.7. Measurement Uncertainty**

Measurement uncertainty: *U* =77 Hz, k=2

## **B.5. 20dB Bandwidth**





#### B.5.1. Reference

See Clause 6.9 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

#### **B.5.2. Measurement Methods**

The transmitter output signal was picked up by coil antenna connected to the spectrum analyzer. The bandwidth of the center frequency was measured with 140Hz RBW, 420Hz VBW and 14kHz span.

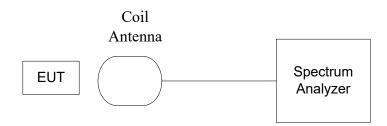


Figure B-8: Measurement Setup

#### **B.5.3. EUT Operating Mode and Test Conditions**

The measurement of EUT was carried out under the transmit state of NFC (See 3.4).

EUT had not been connected to a travel adapter.

During the measurements, the ambient temperature was in the range of 15 ~ 25 °C.

#### **B.5.4. Test Layouts**

See B.5.2.

#### B.5.5. Limits

The 20dB bandwidth shall be less than 80% of the permitted frequency band. For 13.56 MHz NFC, the permitted frequency band is 14kHz, so the limit is 11.2 kHz.

#### **B.5.6. Measurement Results**





Measurement results see Figure B-9.

Conclusions: Set.NFC03, PASS.

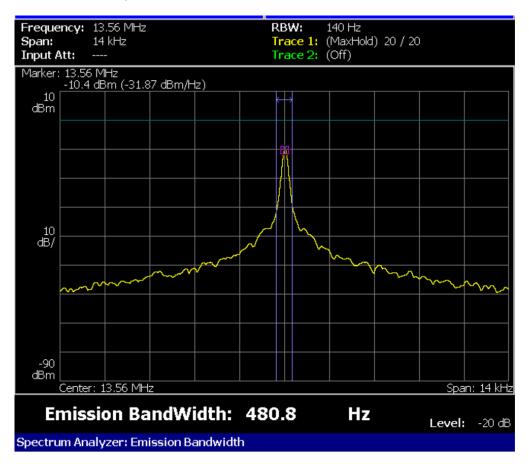


Figure B-9: Measurement results for 20dB Bandwidth

#### **B.5.7. Measurement Uncertainty**

Measurement uncertainty: *U* =77 Hz, k=2

#### **B.6. Conducted emission**

#### B.6.1. Reference

See Clause 6.2 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

#### **B.6.2. Measurement Methods**

The conducted emissions from the AC port of the EUT are measured in a shielding room. The EUT is connected to a Line Impedance Stabilization Network (LISN). An overview sweep with peak detection was performed. The measurements were performed with a quasi-peak detector and if required, an average detector.

The conducted emission measurements were made with the following detector of the test receiver: 
©Copyright. All rights reserved by CTTL.





Quasi-Peak / Average Detector.

The measurement bandwidth is:

Table B-9: Measurement Bandwidth

Frequency of Emission (MHz)	RBW/VBW		
0.15-30	9kHz		

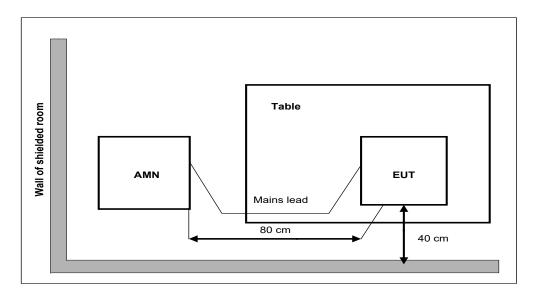


Figure B-10: Measurement Setup

### **B.6.3. EUT Operating Mode and Test Conditions**

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT is powered by a travel adapter.

All possible configurations were investigated and only the worst case is reported.

During the measurements, the ambient temperature is in the range of 15 ~ 25  $\,^{\circ}$ C.

#### B.6.4. Limits

**Table B-10: Limits** 

Frequency range (MHz)	Quasi-peak Limit (dBμV)	Average Limit (dBμV)
0.15 to 0.5	66 to 56	56 to 46
0.5 to 5	56	46
5 to 30	60	50

#### **B.6.5. Measurement Results**

Measurement results see Figure B-11.





Conclusions: Set.NFC01, PASS.

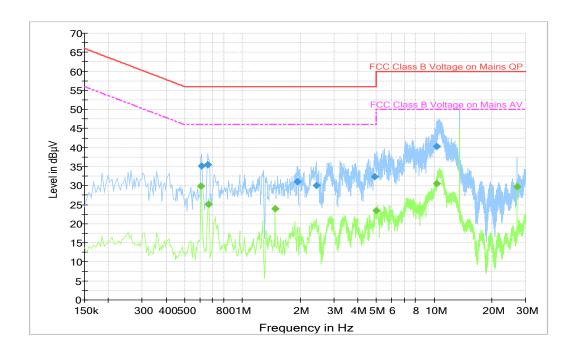


Figure B-11: Measurement results for Conducted Emission

## **Final Result 1**

Frequency	QuasiPeak	Meas. Time	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	(ms)	(kHz)		(dB)	(dB)	(dBµV)
0.613500	35.2	1000.0	9.000	L1	19.6	20.8	56.0
0.658500	35.5	1000.0	9.000	N	19.5	20.5	56.0
1.927500	31.1	1000.0	9.000	N	19.5	24.9	56.0
2.427000	30.0	1000.0	9.000	L1	19.6	26.0	56.0
4.915500	32.4	1000.0	9.000	L1	19.8	23.6	56.0
10.315500	40.2	1000.0	9.000	L1	19.9	19.8	60.0

## Final Result 2

Frequency	Average	Meas. Time	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	(ms)	(kHz)		(dB)	(dB)	(dBµV)
0.609000	29.8	1000.0	9.000	L1	19.6	16.2	46.0
0.667500	25.0	1000.0	9.000	L1	19.6	21.0	46.0
1.482000	24.0	1000.0	9.000	L1	19.6	22.0	46.0
4.992000	23.4	1000.0	9.000	L1	19.8	22.6	46.0
10.315500	30.6	1000.0	9.000	L1	19.9	19.4	50.0
27.123000	29.7	1000.0	9.000	L1	20.2	20.3	50.0





# **ANNEX C: Persons involved in this testing**

Table C-1: Persons involved

Test Item	Tester
20dB Bandwidth	Zhou Bin
Frequency Tolerance	Zhou Bin
Electric Field Strength of Fundamental and Outside the Allocated bands	Zhang Tianli
Electric Field Radiated Emissions (< 30MHz)	Zhang Tianli
Electric Field Radiated Emissions (≥30MHz)	Ding Zai
Conducted Emissions	Yang Mengke





# **ANNEX D: Accreditation Certificate**

# United States Department of Commerce National Institute of Standards and Technology



# Certificate of Accreditation to ISO/IEC 17025:2017

**NVLAP LAB CODE: 600118-0** 

### **Telecommunication Technology Labs, CAICT**

Beijing China

is accredited by the National Voluntary Laboratory Accreditation Program for specific services, listed on the Scope of Accreditation, for:

#### **Electromagnetic Compatibility & Telecommunications**

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated January 2009).

2020-09-29 through 2021-09-30

Effective Dates



For the National Voluntary Laboratory Accreditation Program

\*\*\*END OF REPORT\*\*\*